

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10595310	YAMASHITA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	SING P CHAN	1791

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
156	230-235, 246, 247	10/10/08	SPC
428	469, 472	10/10/08	SPC
156	230-235, 246, 247	3/9/09	SPC
428	469, 472	3/9/09	SPC
156	230-235, 246, 247	9/3/09	SPC
428	469, 472	9/3/09	SPC
156	230-235, 246, 247	1/27/10	SPC
428	439, 472	1/27/10	SPC

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text and image search on EAST	10/10/08	SPC
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	10/10/08	SPC
Text and image search on EAST	3/9/09	SPC
Inventors search on EAST and PALM on akio yamashita, yumiko fukumoto, and yuugo goto	3/9/09	SPC
Text and image search on EAST	9/3/09	SPC
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	9/3/09	SPC
Text and image search on EAST	1/27/10	SPC
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	1/27/10	SPC

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>